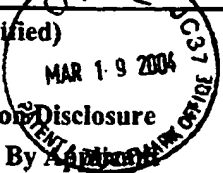


<b>Form 1449 (Modified)</b> <div style="text-align: center;">   <b>Information Disclosure</b>  <b>Statement By Applicant</b>    (Use Several Sheets if Necessary) </div>	<b>Atty Docket No.</b>	SDK1P014/370
	<b>Application No.:</b>	10/602,373
	<b>Applicant</b>	Takiar
	<b>Filing Date</b>	June 23, 2003
	<b>Group</b>	2812

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Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class	Filing Date
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<i>[Signature]</i>	O.	High Capacity and Small Size, Meeting the Storage Needs of Today's Portable Devices, 2003 SanDisk Corporation.
<i>[Signature]</i>	P.	Dean et al., "New Fine-Beam, Abrasive Water Jet Technology Enables Photonic and Small Device Singulation," Chip Scale Review, August/September 2002, pp.43, 45, 47.
<i>[Signature]</i>	Q.	U.S. Patent Application No. 10/621,882, by Hem P. Takiar, filed July 17, 2003.
Examiner <i>[Signature]</i>		Date Considered 12/10/2004

Examiner. Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.